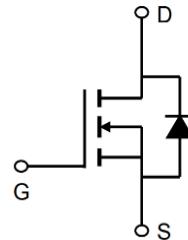


## Description

The AP200N12P/T uses advanced **SGT<sub>T</sub>** technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 10V. This device is suitable for use as a Battery protection or in other Switching application.



## General Features

$V_{DS} = 120V$  (**Type: 135V**)  $I_D = 200A$

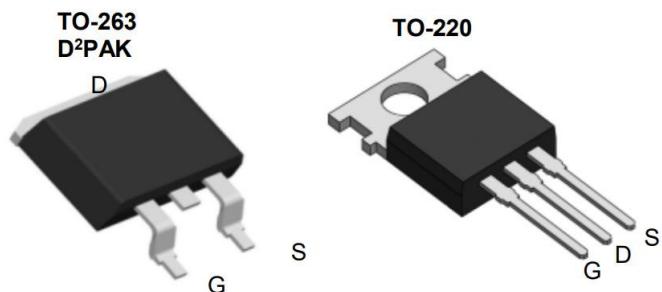
$R_{DS(ON)} < 4.2m\Omega$  @  $V_{GS}=10V$  (**Type: 3.7m\Omega**)

## Application

BMS

UPS

Power Management Switches



## Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP200N12P	TO-220-3L	AP200N12P XXX YYYY	1000
AP200N12T	TO-263-3L	AP200N12T XXX YYYY	800

## Absolute Maximum Ratings ( $T_c=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	120	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D @ T_c=25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	200	A
$I_D @ T_c=100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	150	A
$I_{DM}$	Pulsed Drain Current	600	A
$E_{AS}$	Single Pulse Avalanche Energy	530	mJ
$I_{AS}$	Avalanche Current	45	A
$P_D @ T_c=25^\circ C$	Total Power Dissipation <sup>4</sup>	240	W
$T_{STG}$	Storage Temperature Range	-55 to 150	°C
$T_J$	Operating Junction Temperature Range	-55 to 150	°C
$R_{\theta JA}$	Thermal Resistance Junction-Ambient	0.75	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-Case	62	°C/W



**120V N-Channel Enhancement Mode MOSFET**
**Electrical Characteristics ( $T_c=25^\circ\text{C}$  unless otherwise noted)**

Symbol	Parameter	Test Conditions	Min.	Type	Max.	Unit
VDSS	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$	120	135	-	V
IGSS	Gate-body Leakage current	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$	-	-	$\pm 100$	nA
IDSS	Zero Gate Voltage Drain Current $T_J=25^\circ\text{C}$	$V_{DS} = 120\text{V}, V_{GS} = 0\text{V}$	-	-	1	$\mu\text{A}$
IDSS	Zero Gate Voltage Drain Current $T_J=100^\circ\text{C}$		-	-	100	
VGS(th)	Gate-Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2.0	2.9	4.0	V
RDS(on)	Drain-Source on-Resistance <sup>2</sup>	$V_{GS} = 10\text{V}, I_D = 20\text{A}$	-	3.7	4.2	$\text{m}\Omega$
RDS(on)	Drain-Source on-Resistance <sup>2</sup>	$V_{GS} = 6\text{V}, I_D = 20\text{A}$		4.3	5.8	$\text{m}\Omega$
Ciss	Input Capacitance	$V_{GS} = 0\text{V}, V_{DS} = 60\text{V}, f = 250\text{kHz}$	-	5240	-	pF
Coss	Output Capacitance		-	739	-	
Crss	Reverse Transfer Capacitance		-	12	-	
R <sub>g</sub>	Gate Resistance	$V_{GS} = 0\text{V}, V_{DS} = 0\text{V}, f = 1\text{MHz}$	-	1.7	-	$\Omega$
Q <sub>g</sub>	Total Gate Charge	$V_{DD} = 60\text{V}, I_D = 45\text{A}, V_{GS} = 0 \text{ to } 10\text{V}$	-	19	-	nC
Q <sub>gs</sub>	Gate-Source Charge		-	11	-	
Q <sub>gd</sub>	Gate-Drain Charge		-	75	-	
td(on)	Turn-on Delay Time	$V_{DD} = 60\text{V}, V_{GS} = 10\text{V}, I_D = 45\text{A}, R_G = 10\Omega$	-	59	-	ns
t <sub>r</sub>	Rise Time		-	41	-	
td(off)	Turn-off Delay Time		-	96	-	
t <sub>f</sub>	Fall Time		-	33	-	
VSD	Diode Forward Voltage <sup>2</sup>	$I_F = 20\text{A}, V_{GS} = 0\text{V}$	-	0.8	1.2	V
IS	Continuous Source Current <sup>1,5</sup>	$V_G = V_D = 0\text{V}$ , Force Current	-	-	200	A
trr	Body Diode Reverse Recovery Time	$VR = 60\text{V} I_F = 35\text{A}, dI/dt = 100\text{A}/\mu\text{s}$	-	70	-	ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge		-	200	-	nC

**Notes:**

- 1、The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2、The data tested by pulsed , pulse width  $\leq 300\mu\text{s}$  , duty cycle  $\leq 2\%$
- 3、The EAS data shows Max. rating . The test condition is  $V_{DD}=50\text{V}, V_{GS}=10\text{V}, L=0.5\text{mH}, I_{AS}=45\text{A}$
- 4、The power dissipation is limited by  $150^\circ\text{C}$  junction temperature
- 5、The data is theoretically the same as  $I_D$  and  $I_{DM}$  , in real applications , should be limited by total power dissipation.

### Typical Characteristics

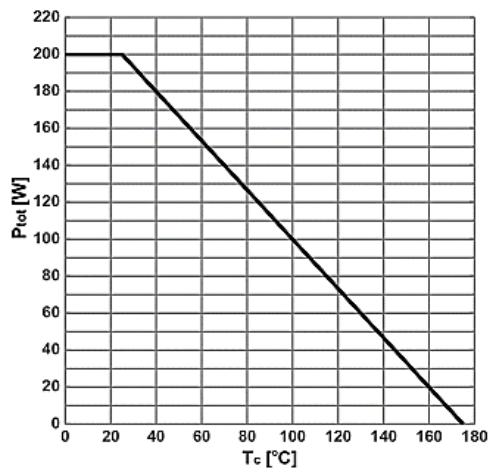


Figure 1. Power dissipation

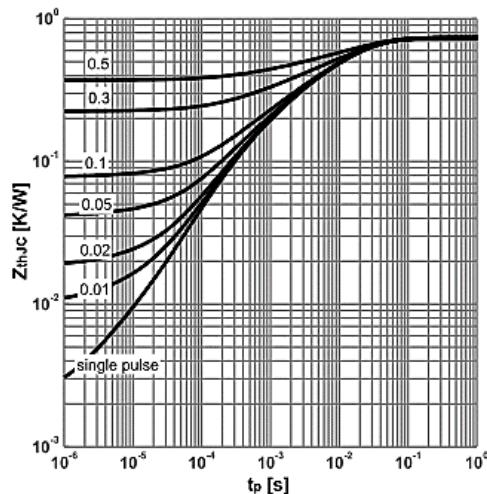


Figure 2. Max. transient thermal impedance

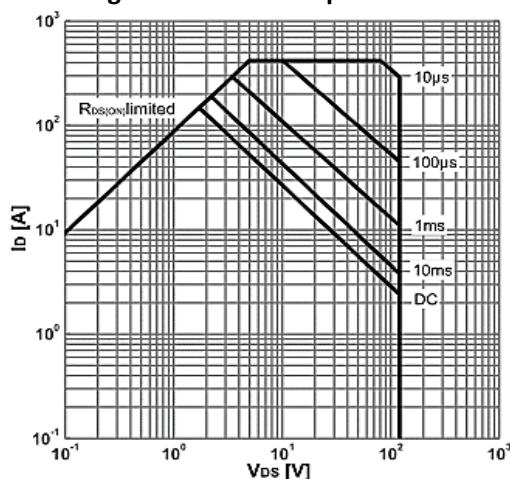


Figure 3. Safe operating area

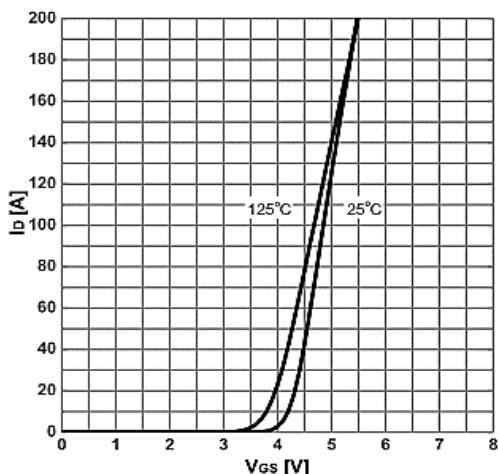


Figure 4. Typ. transfer characteristics

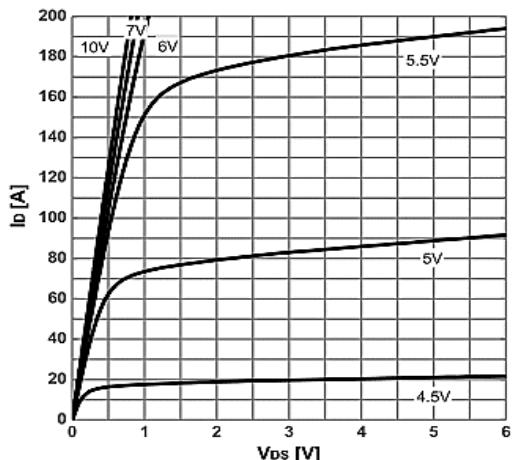


Figure 5. Typ. output characteristics( $T_j = 25^\circ\text{C}$ )

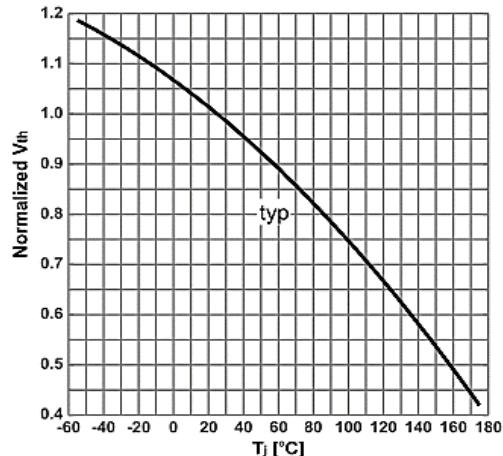


Figure 6. Typ. output characteristics( $T_j = 125^\circ\text{C}$ )

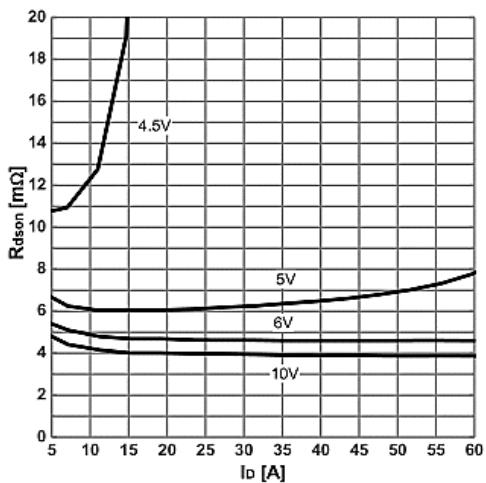


Figure 7. On-state resistance vs. Drain current

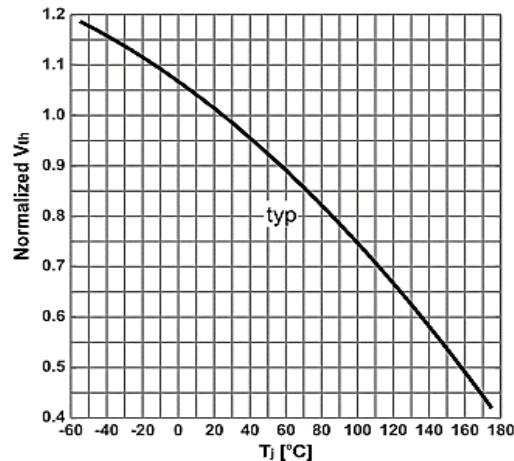


Figure 6. Gate threshold voltage vs. Junction Temperature

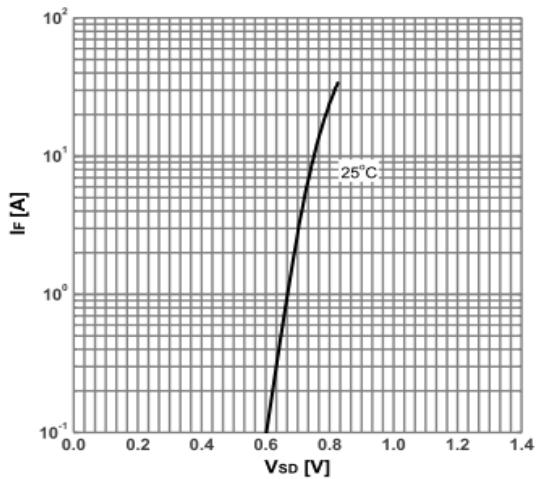


Figure 9. Forward characteristics of reverse diode

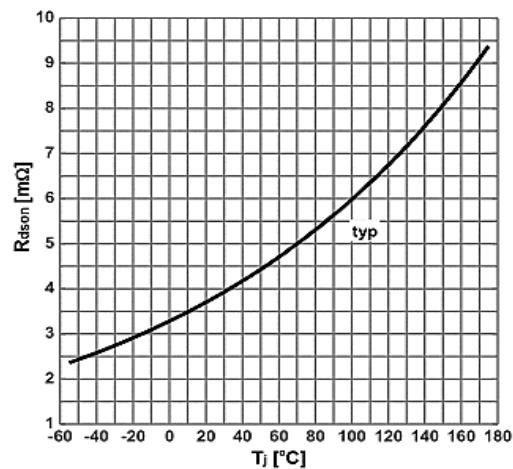


Figure 8. On-state resistance vs. Junctiontemperature

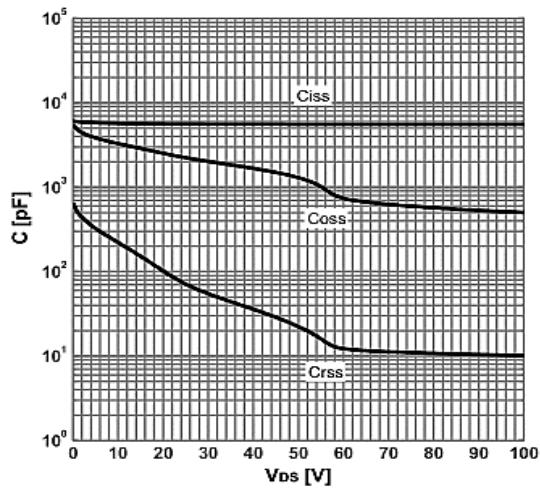


Figure9 Typ. capacitances

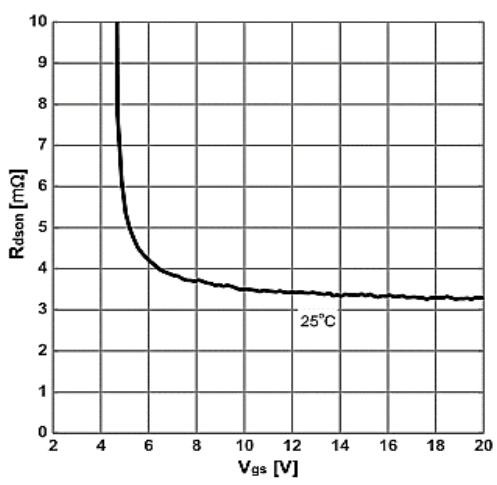


Figure11. On-state resistance vs. Vgs characteristics

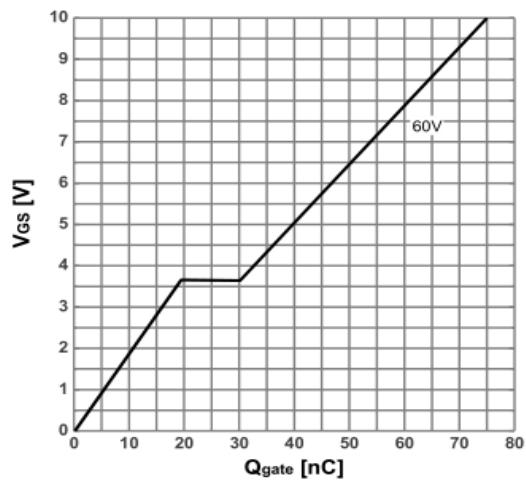
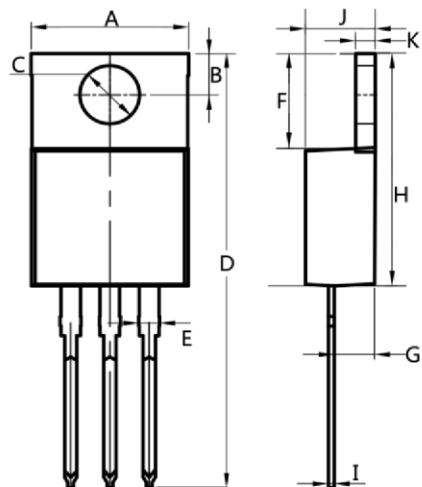


Figure 13: Typ. gate charge

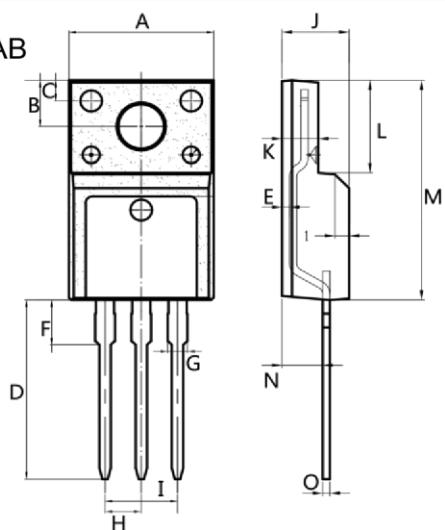
TO-220AB



Dim.	Min.	Max.
A	10.0	10.4
B	2.5	3.0
C	3.5	4.0
D	28.0	30.0
E	1.1	1.5
F	6.2	6.6
G	2.9	3.3
H	15.0	16.0
I	0.35	0.45
J	4.3	4.7
K	1.2	1.4

All Dimensions in millimeter

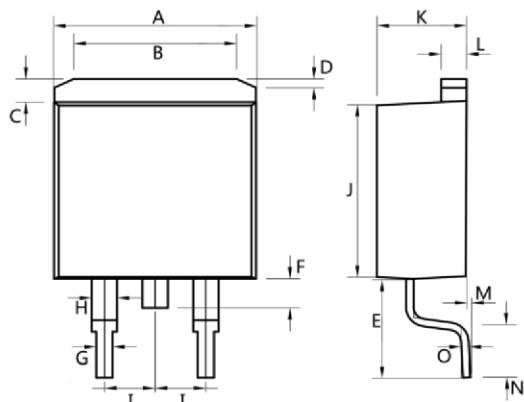
ITO-220AB



Dim.	Min.	Max.
A	9.9	10.3
B	2.9	3.5
C	1.15	1.45
D	12.75	13.25
E	0.55	0.75
F	3.1	3.5
G	1.25	1.45
H	Typ 2.54	
I	Typ 5.08	
J	4.55	4.75
K	2.4	2.7
L	6.35	6.75
M	15.0	16.0
N	2.75	3.15
O	0.45	0.60

All Dimensions in millimeter

TO-263



Dim.	Min.	Max.
A	10.0	10.5
B	7.25	7.75
C	1.3	1.5
D	0.55	0.75
E	5.0	6.0
F	1.4	1.6
G	0.75	0.95
H	1.15	1.35
I	Typ 2.54	
J	8.4	8.6
K	4.4	4.6
L	1.25	1.45
M	0.02	0.1
N	2.4	2.8
O	0.35	0.45

All Dimensions in millimeter